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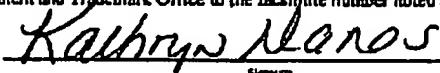
IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: JOYCE S. OEV HEWETT ALEXANDER J. PASADYN	Group Art Unit: 2823
Serial No.: 09/909,074	Examiner: KHIEM D. NGUYEN
Filed: JULY 19, 2001	Conf. No.: 9763
For: METHOD AND APPARATUS FOR CONTROLLING A THICKNESS OF A CONDUCTIVE LAYER IN A SEMICONDUCTOR MANUFACTURING OPERATION	Atty. Dkt.: 2000.075200/TT4629 CUSTOMER NO.: 23720

K. N.
03/08/05RESPONSE TO FINAL OFFICE ACTION OF JANUARY 5, 2005

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

CERTIFICATE OF TRANSMISSION UNDER 37 CFR 1.6(d)	
DATE OF FACSIMILE:	03.02.2005
FACSIMILE NO.:	(703) 872-9306
I hereby certify that this paper or fax is being facsimile to the United States Patent and Trademark Office to the facsimile number noted above.	
 Signature	

This paper is submitted in response to the Office Action mailed January 5, 2005 for which the shortened three-month statutory response date is April 5, 2005.

Remarks begin on page 3 of this paper.

If an extension of time is required to enable this paper to be timely filed and there is no separate Petition for Extension of Time filed herewith, this paper is to be construed as also constituting a Petition for Extension of Time Under 37 CFR § 1.136(a) for a period of time sufficient to enable this document to be timely filed.